Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/706,097	PAN ET AL.	
Examiner	Art Unit	_
HOAN C. NGUYEN	2871	

SEARCHED				
Class	Subclass	Date	Examiner	
349	update	7/26/2006	CHN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
East search in US-PGPUB, USPAT, EPO, JPO, Derwent and IBM_TDB	7/26/2006	CHN